

MOS FIELD EFFECT TRANSISTOR $\mu PA1790$

SWITCHING N-AND P-CHANNEL POWER MOS FET

DESCRIPTION

The μ PA1790 is N-and P-Channel MOS Field Effect Transistor designed for motor driver applications.

FEATURES

- Dual chip type
- Low on-state resistance

N-Channel $R_{DS(on)1} = 0.12 \ \Omega$ TYP. (Vgs = 10 V, ID = 0.5 A) $R_{DS(on)2} = 0.19 \ \Omega$ TYP. (Vgs = 4 V, ID = 0.5 A)

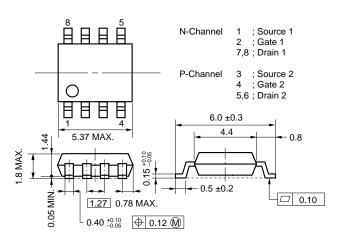
Low input capacitance
 N-Channel Ciss = 180 pF TYP.

- P-Channel Ciss = 230 pF TYP.
- Built-in G-S protection diode
- Small and surface mount package (Power SOP8)

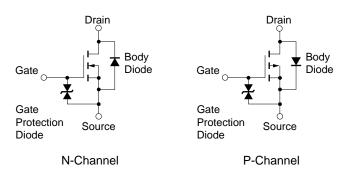
ORDERING INFORMATION

| PART NUMBER | PACKAGE | | |
|-------------|------------|--|--|
| μΡΑ1790G | Power SOP8 | | |

PACKAGE DRAWING (Unit: mm)



EQUIVALENT CIRCUIT



Remarks 1. This product is designed for consumer application and isn't suitable for automotive application.

2. The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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The mark \star shows major revised points.

| ABSOLUTE MAANWOWINATINGS (TA = 25 G, All terminals are connected.) | ABSOLUTE MAXIMUM RATINGS (| T _A = 25°C, All terminals are connected.) |
|--|-----------------------------------|--|
|--|-----------------------------------|--|

| PARAMETER | SYMBOL | N-CHANNEL | P-CHANNEL | UNIT |
|---|----------|------------|-----------|------|
| Drain to Source Voltage (V _{GS} = 0 V) | VDSS | 60 | V | |
| Gate to Source Voltage (V _{DS} = 0 V) | Vgss | ±20 | V | |
| Drain Current (DC) | ID(DC) | ±1.0 ∓ 0.7 | | А |
| Drain Current (pulse) Note1 | D(pulse) | ±4.0 ∓ 2.8 | | А |
| Total Power Dissipation (1 unit) Note2 | Ρτ | 1 | W | |
| Total Power Dissipation (2 unit) Note2 | Ρτ | 2 | W | |
| Channel Temperature | Tch | 15 | °C | |
| Storage Temperature | Tstg | –55 to | °C | |
| ★ Single Avalanche Current Note3 | las | 0.5 | -0.35 | А |
| ★ Single Avalanche Energy Note3 | Eas | 0.02 | 0.01 | mJ |

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Mounted on ceramic substrate of $2000 \text{ mm}^2 \text{ x} 2.25 \text{ mm}$

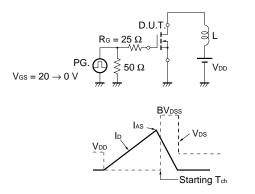
3. Starting T_ch = 25°C, V_DD = 30 V, R_G = 25 Ω , V_Gs = 20 \rightarrow 0 V

ELECTRICAL CHARACTERISTICS (T_A = 25°C, All terminals are connected.)

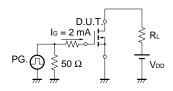
N-CHANNEL

| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|--|------|------|------|------|
| Zero Gate Voltage Drain Current | IDSS | Vds = 60 V, Vgs = 0 V | | | 10 | μA |
| Gate Leakage Current | lgss | $V_{GS} = \pm 16 \text{ V}, \text{ Vds} = 0 \text{ V}$ | | | ±10 | μA |
| Gate Cut-off Voltage | V _{GS(off)} | Vds = 10 V, Id = 1 mA | 1.0 | 1.7 | 2.5 | V |
| Forward Transfer Admittance | y _{fs} | Vds = 10 V, Id = 0.5 A | 1.0 | 1.7 | | S |
| Drain to Source On-state Resistance | RDS(on)1 | Vgs = 10 V, Id = 0.5 A | | 0.12 | 0.26 | Ω |
| | RDS(on)2 | Vgs = 4 V, Id = 0.5 A | | 0.19 | 0.34 | Ω |
| Input Capacitance | Ciss | V _{DS} = 10 V | | 180 | | pF |
| Output Capacitance | Coss | Vgs = 0 V | | 100 | | pF |
| Reverse Transfer Capacitance | Crss | f = 1 MHz | | 35 | | pF |
| Turn-on Delay Time | td(on) | Vdd = 30 V, Id = 0.5 A | | 1 | | ns |
| Rise Time | tr | Vgs = 10 V | | 1.4 | | ns |
| Turn-off Delay Time | td(off) | R _G = 10 Ω | | 23 | | ns |
| Fall Time | tr | | | 17 | | ns |
| Total Gate Charge | Q _G | V _{DD} = 48 V | | 8 | | nC |
| Gate to Source Charge | Q _{GS} | Vgs = 10 V | | 1 | | nC |
| Gate to Drain Charge | Qgd | ID = 1.0 A | | 3.5 | | nC |
| Body Diode Forward Voltage | VF(S-D) | IF = 1.0 A, VGs = 0 V | | 0.75 | | V |
| Reverse Recovery Time | trr | IF = 1.0 A, VGS = 0 V | | 30 | | ns |
| Reverse Recovery Charge | Qrr | di/dt = 100 A/ μs | | 33 | | nC |

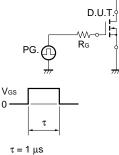
TEST CIRCUIT 1 AVALANCHE CAPABILITY



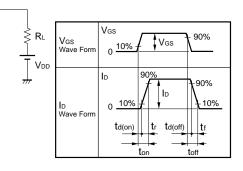
TEST CIRCUIT 3 GATE CHARGE



TEST CIRCUIT 2 SWITCHING TIME



Duty Cycle ≤ 1%

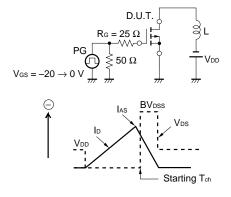


Data Sheet G14320EJ2V0DS

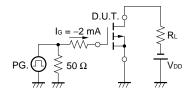
P-CHANNEL

| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|---|------|------|-------------|------|
| Zero Gate Voltage Drain Current | IDSS | Vds = -60 V, Vgs = 0 V | | | -10 | μA |
| Gate Leakage Current | lgss | $V_{GS} = \mp 16 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$ | | | ∓ 10 | μA |
| Gate Cut-off Voltage | V _{GS(off)} | $V_{DS} = -10 V$, $I_D = -1 mA$ | -1.0 | -1.7 | -2.5 | V |
| Forward Transfer Admittance | y _{fs} | $V_{DS} = -10 \text{ V}, \text{ Id} = -0.35 \text{ A}$ | 0.5 | 0.9 | | S |
| Drain to Source On-state Resistance | RDS(on)1 | $V_{GS} = -10 \text{ V}, \text{ Id} = -0.35 \text{ A}$ | | 0.45 | 0.6 | Ω |
| | RDS(on)2 | $V_{GS} = -4 V$, $I_D = -0.35 A$ | | 0.74 | 1.1 | Ω |
| Input Capacitance | Ciss | V _{DS} = -10 V | | 230 | | pF |
| Output Capacitance | Coss | V _{GS} = 0 V | | 100 | | pF |
| Reverse Transfer Capacitance | Crss | f = 1 MHz | | 25 | | pF |
| Turn-on Delay Time | td(on) | $V_{DD} = -30 \text{ V}, \text{ Id} = -0.35 \text{ A}$ | | 1.9 | | ns |
| Rise Time | tr | Vgs = -10 V | | 1.7 | | ns |
| Turn-off Delay Time | td(off) | R _G = 10 Ω | | 30 | | ns |
| Fall Time | tr | | | 15 | | ns |
| Total Gate Charge | QG | V _{DD} = -48 V | | 7.6 | | nC |
| Gate to Source Charge | QGS | V _{GS} = -10 V | | 1 | | nC |
| Gate to Drain Charge | Qgd | ID = -0.7 A | | 2 | | nC |
| Body Diode Forward Voltage | VF(S-D) | IF = 0.7 A, VGS = 0 V | | 0.85 | | V |
| Reverse Recovery Time | trr | IF = 0.7 A, VGS = 0 V | | 58 | | ns |
| Reverse Recovery Charge | Qrr | di/dt = 100 A/ μs | | 130 | | nC |

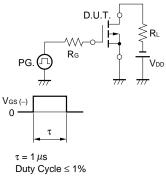
TEST CIRCUIT 1 AVALANCHE CAPABILITY

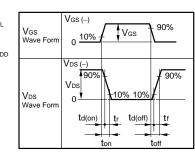


TEST CIRCUIT 3 GATE CHARGE



TEST CIRCUIT 2 SWITCHING TIME

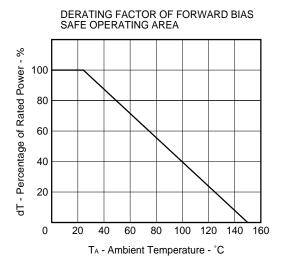




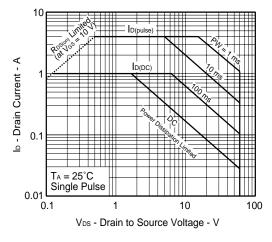
* TYPICAL CHARACTERISTICS (TA = 25°C, All terminals are connected.)

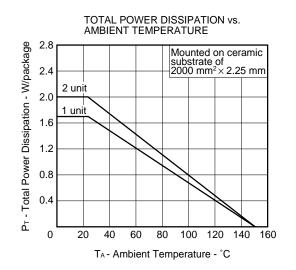
N-CHANNEL

NEC



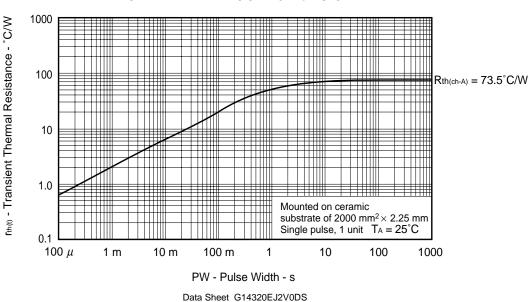
FORWARD BIAS SAFE OPERATING AREA





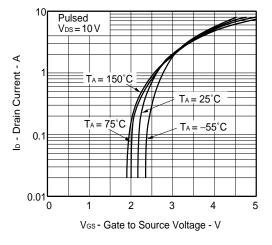
Remark Mounted on ceramic substrate of

2000 mm² \times 2.25 mm

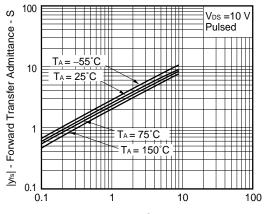


TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

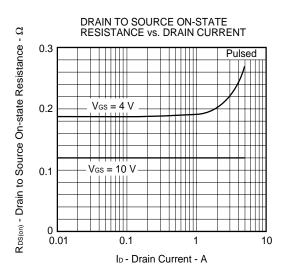


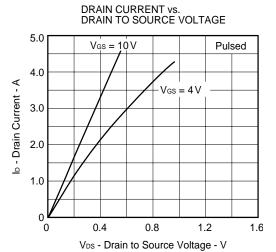




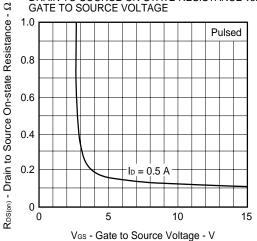




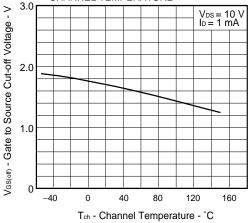


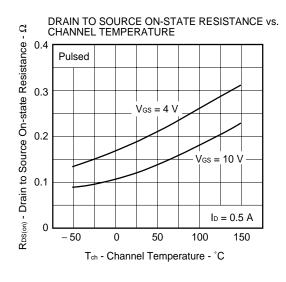


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

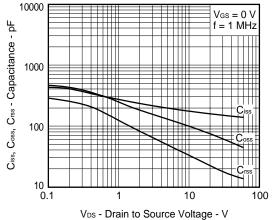




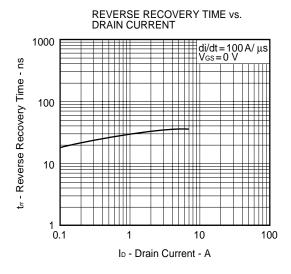


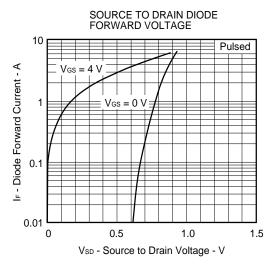




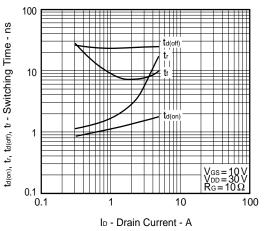




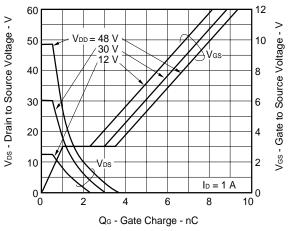




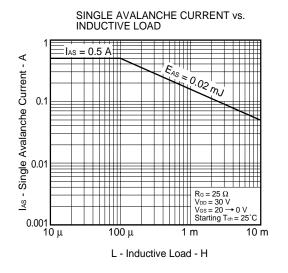
SWITCHING CHARACTERISTICS

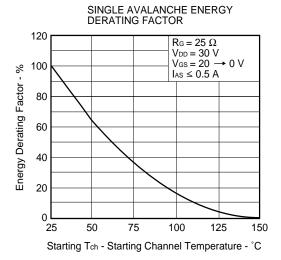






Data Sheet G14320EJ2V0DS

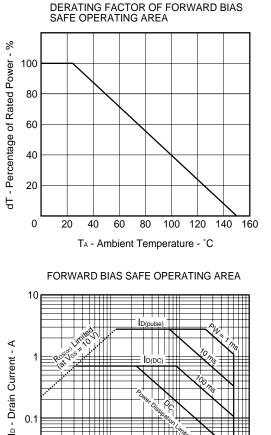


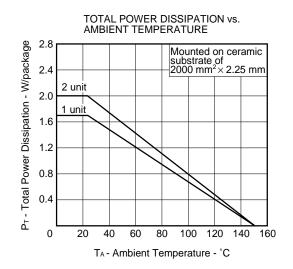


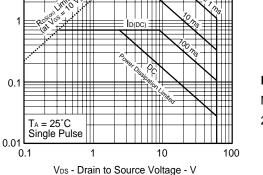
★ TYPICAL CHARACTERISTICS (TA = 25°C, All terminals are connected.)

P-CHANNEL

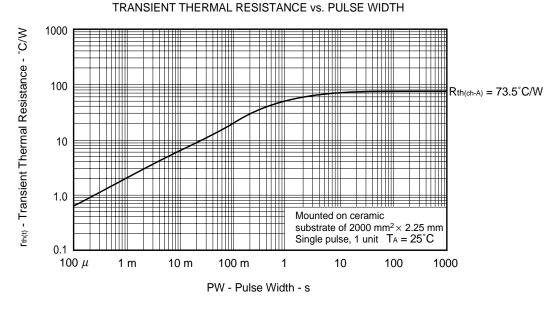
NEC



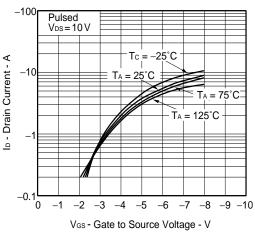




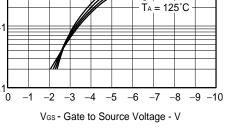
Remark Mounted on ceramic substrate of 2000 $mm^2 \times 2.25 mm$



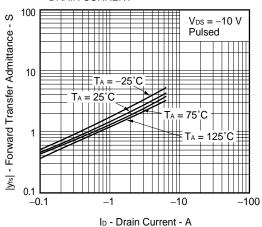
Data Sheet G14320EJ2V0DS

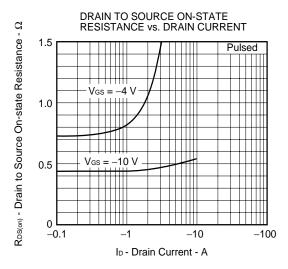












-5.0 Pulsed -4.0 -3.0 Vgs = -10 V -2.0 $V_{GS} = -4 V$

-1.0

VDS - Drain to Source Voltage - V

-1.5

-2.0

DRAIN TO SOURCE VOLTAGE

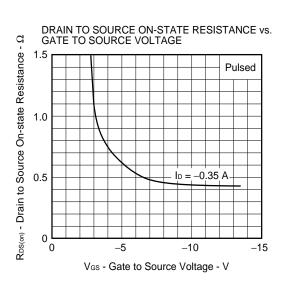
DRAIN CURRENT vs.

Ip - Drain Current - A

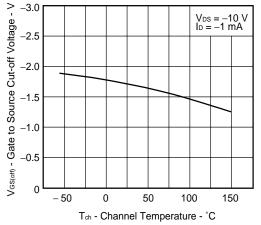
-1.0

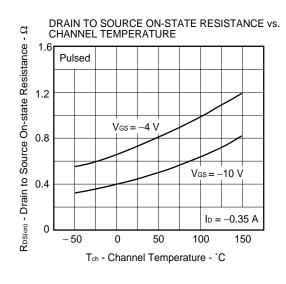
0 0

-0.5

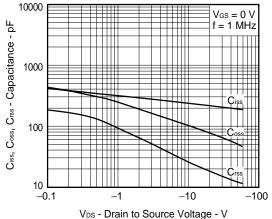


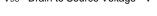
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



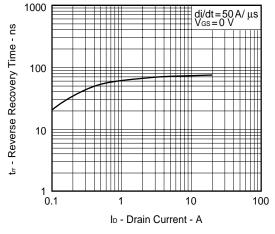


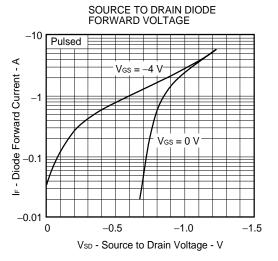




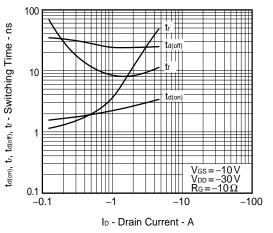




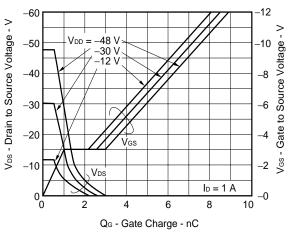




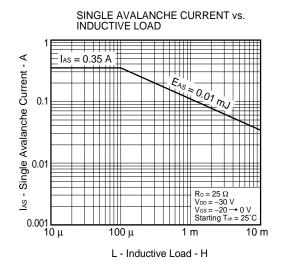
SWITCHING CHARACTERISTICS

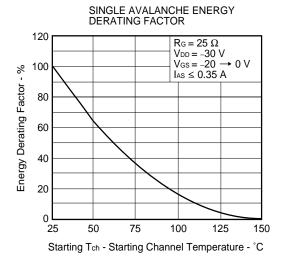






Data Sheet G14320EJ2V0DS





[MEMO]

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